



AOD410

N-Channel Enhancement Mode Field Effect Transistor

General Description			Features		
The AOD410 uses advanced trench technology to provide excellent R _{DS(ON)} and low gate charge. This device is suitable for use as a load switch or in PWM applications. -RoHS Compliant -Halogen Free*			$\begin{split} V_{DS} & (V) = 30V \\ I_{D} = 8A \; (V_{GS} = 10V) \\ R_{DS(ON)} < 65m\Omega (V_{GS} = 10V) \\ R_{DS(ON)} < 105m\Omega \; (V_{GS} = 4.5V) \end{split}$		
			100% UIS Tested! 100% Rg Tested!		
Top Vie	TO-252 D-PAK Bottom View				
	G S S	G	G		
	Ratings T _A =25°C unless			Units	
Parameter	Ratings T _A =25°C unless	Symbol	oted Maximum 30	Units V	
Parameter Drain-Source Voltage	Ratings T _A =25°C unless	Symbol V _{DS}	Maximum		
Parameter Drain-Source Voltage Gate-Source Voltage	Ratings T _A =25°C unless	Symbol	Maximum 30	V	
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain	Ratings T _A =25°C unless e T _C =25°C	Symbol V _{DS}	Maximum 30 ±20	V	
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current ^G	Ratings $T_A=25^{\circ}C$ unless e T_C=25^{\circ}C T_C=100^{\circ}C	Symbol V _{DS} V _{GS}	Maximum 30 ±20 8	V V	
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current ^G Pulsed Drain Current	Ratings $T_A = 25^{\circ}C$ unless e N e N T_C = 25^{\circ}C N T_C = 100^{\circ}C I	Symbol V _{DS} V _{GS}	Maximum 30 ±20 8 6	V V	
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current ^G Pulsed Drain Current Avalanche Current ^C	Ratings $T_A = 25^{\circ}C$ unless e N e N T_C = 25^{\circ}C N T_C = 100^{\circ}C I t B I	Symbol V _{DS} V _{GS} D D AR	Maximum 30 ±20 8 6 20	V V A	
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current ^G Pulsed Drain Current Avalanche Current ^C	Ratings $T_A = 25^\circ C$ unless e N e N T_C = 25^\circ C T T_C = 100^\circ C I t B I e energy L=0.1mH ^C I T_C = 25^\circ C I	Symbol V _{DS} V _{GS} D D AR E _{AR}	Maximum 30 ±20 8 6 20 8 8	V V A A M M J	
Absolute Maximum Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current ^G Pulsed Drain Current Avalanche Current ^C Repetitive avalanche Power Dissipation ^B	Ratings $T_A = 25^\circ C$ unless e N e N T_C = 25^\circ C T T_C = 100^\circ C I t B I e energy L=0.1mH ^C I T_C = 25^\circ C I	Symbol V _{DS} V _{GS} D D AR	Maximum 30 ±20 8 6 20 8 10	V V A A	
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current ^G Pulsed Drain Current Avalanche Current ^C Repetitive avalanche	Ratings $T_A=25^{\circ}C$ unlesseYT_C=25^{\circ}CT_C=100^{\circ}Ct Be energy L=0.1mH cET_C=25^{\circ}CT_C=100^{\circ}CT_C=100^{\circ}CT_C=25^{\circ}CT_C=100^{\circ}CT_C=25^{\circ}C	Symbol V _{DS} V _{GS} D D D AR E _{AR} P _D	Maximum 30 ±20 8 6 20 8 10 25	V V A A mJ W	
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current ^G Pulsed Drain Current Avalanche Current ^C Repetitive avalanche	Ratings $T_A=25^{\circ}C$ unlesseYT_C=25^{\circ}CT_C=100^{\circ}Ct Be energy L=0.1mH cET_C=25^{\circ}CT_C=100^{\circ}CT_C=100^{\circ}CT_C=25^{\circ}CT_C=100^{\circ}CT_C=25^{\circ}C	Symbol V _{DS} V _{GS} D D AR E _{AR}	Maximum 30 ±20 8 6 20 8 10 25 12.5	V V A A M M J	

Thermal Characteristics								
Parameter		Symbol	Тур	Max	Units			
Maximum Junction-to-Ambient A	t ≤ 10s	R _{0JA}	20	30	°C/W			
Maximum Junction-to-Ambient A	Steady-State	Γ _{θJA}	46	60	°C/W			
Maximum Junction-to-Case ^C	Steady-State	$R_{ ext{ hetaJL}}$	5.3	7	°C/W			



Electrical Characteristics (Tj=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V		30			V
	Zero Gate Voltage Drain Current	V _{DS} =24V, V _{GS} =0V				1	μA
			T _J =55°C			5	μΑ
I _{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} = ±20V				100	nA
V _{GS(th)}	Gate Threshold Voltage	$V_{DS}=V_{GS}$ I _D =250µA		1	1.8	3	V
I _{D(ON)}	On state drain current	V_{GS} =4.5V, V_{DS} =5V		10			Α
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =8A			48	65	mΩ
			T _J =125°C		76	100	
		V _{GS} =4.5V, I _D =2A			75	105	mΩ
g _{FS}	Forward Transconductance	V _{DS} =5V, I _D =8A			6.2		S
V _{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.75	1	V
I _S	Maximum Body-Diode Continuous Current					4.3	Α
DYNAMI	C PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =15V, f=1MHz V _{GS} =0V, V _{DS} =0V, f=1MHz			288		pF
C _{oss}	Output Capacitance				57		pF
C _{rss}	Reverse Transfer Capacitance				39		pF
R _g	Gate resistance				3		Ω
SWITCHI	NG PARAMETERS						
Q _g (10V)	Total Gate Charge	V _{GS} =10V, V _{DS} =15V, I _D =8A			6.72		nC
Q _g (4.5V)	Total Gate Charge				3.34		nC
Q _{gs}	Gate Source Charge				0.76		nC
Q_{gd}	Gate Drain Charge				1.78		nC
t _{D(on)}	Turn-On DelayTime	V_{GS} =10V, V_{DS} =15V, R_{L} =1.8 Ω , R_{GEN} =3 Ω			3.7		ns
t _r	Turn-On Rise Time				3.7		ns
t _{D(off)}	Turn-Off DelayTime				15.6		ns
t _f	Turn-Off Fall Time				2.6		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =8A, dl/dt=100A/μs			12.6		ns
Q _{rr}	Body Diode Reverse Recovery Charg	e I _F =8A, dI/dt=100A/μs			5.1		nC

A: The value of R_{0JA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^{\circ}$ C. The Power dissipation P_{DSM} is based on R _{0JA} and the maximum allowed junction temperature of 150°C. The value in any a given application depends on the user's specific board design, and the maximum temperature for 175°C may be used if the PCB allows it.

B. The power dissipation P_D is based on $T_{J(MAX)}$ =175°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C: Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}$ =175°C.

D. The $R_{\theta JA}$ is the sum of the thermal impedence from junction to case $R_{\theta JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

F. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The SOA curve provides a single pulse rating.

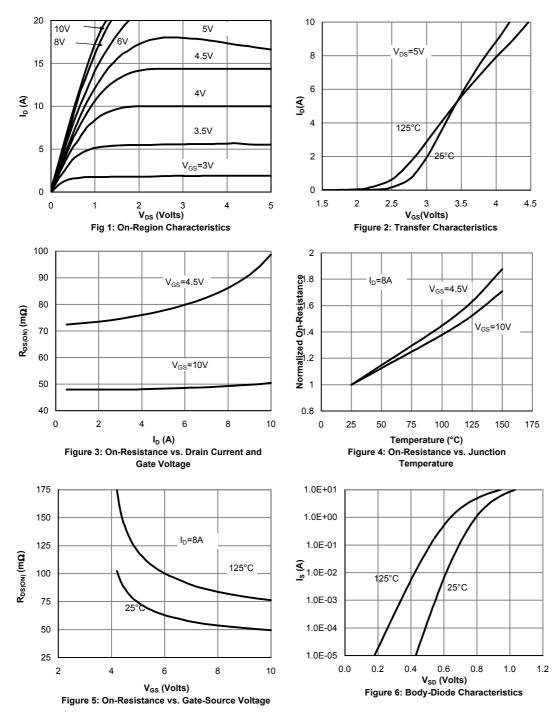
G. The maximum current rating is limited by bond-wires.

*This device is guaranteed green after data code 8X11 (Sep 1^{ST} 2008).

Rev4: Oct 2008

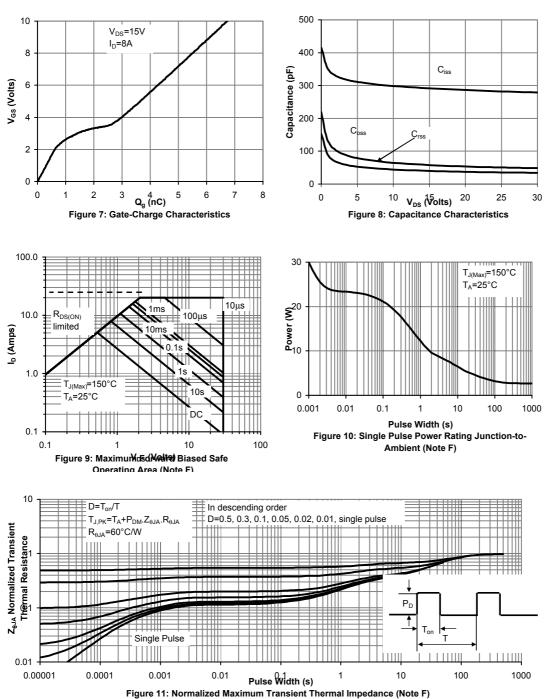
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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

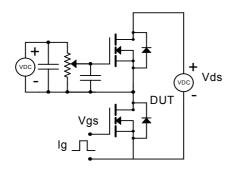


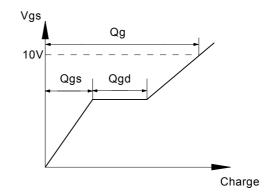


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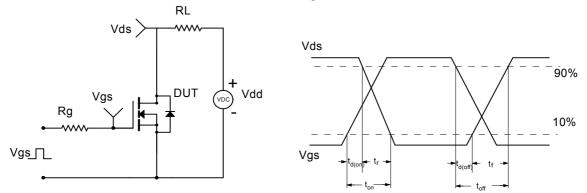


Gate Charge Test Circuit & Waveform

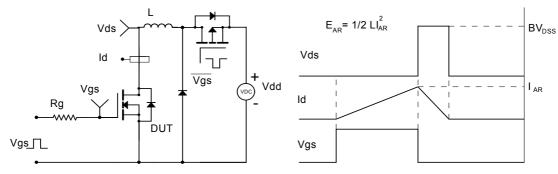




Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

